

## 10µA Supply Current, Low I<sub>B</sub>, Zero-Drift Operational Amplifier

#### **FEATURES**

- Low Supply Current: 10µA Maximum (per Amplifier)
- Offset Voltage: 5µV Maximum
- Offset Voltage Drift: 0.02µV/°C Maximum
- Input Bias Current:
  - 5pA Typical
  - 50pA Maximum, -40°C to 85°C
  - 150pA Maximum, -40°C to 125°C
- Integrated EMI Filter (90dB Rejection at 1.8GHz)
- Shutdown Current: 170nA Maximum (per Amplifier)
- Rail-to-Rail Input and Output
- 1.7V to 5.25V Operating Supply Range
- A<sub>VOI</sub>: 140dB Typical
- Low-Charge Power-Up for Duty Cycled Applications
- Specified Temperature Ranges:
  - -40°C to 85°C
  - -40°C to 125°C
- SC70, TSOT23, MS8, DFN10, TSSOP14 and QFN16 Packages

#### **APPLICATIONS**

- Signal Conditioning in Wireless Mesh Networks
- Portable Instrumentation Systems
- Low-Power Sensor Conditioning
- Gas Detection
- Temperature Measurement
- Medical Instrumentation
- Energy Harvesting Applications
- Low Power Current Sensing

#### DESCRIPTION

The LTC®2066/LTC2067/LTC2068 are single, dual, and quad low power, zero-drift, 100kHz amplifiers. The LTC2066/LTC2067/LTC2068 enable high resolution measurement at extremely low power levels.

Typical supply current is  $7.5\mu A$  per amplifier with a maximum of  $10\mu A$ . The available shutdown mode has been optimized to minimize power consumption in duty-cycled applications and features low charge loss during powerup, reducing total system power.

The LTC2066/LTC2067/LTC2068's self-calibrating circuitry results in very low input offset ( $5\mu V$  max) and offset drift ( $0.02\mu V/^{\circ}C$ ). The maximum input bias current is only 35pA and does not exceed 150pA over the full specified temperature range. The extremely low input bias current of the LTC2066/LTC2067/LTC2068 allows the use of high value power-saving resistors in the feedback network.

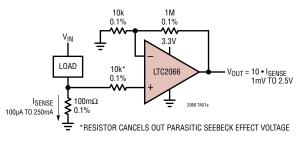
With its ultralow quiescent current and outstanding precision, the LTC2066/LTC2067/LTC2068 can serve as a signal chain building block in portable, energy harvesting and wireless sensor applications.

The LTC2066 is available in 6-lead SC70 and 5-lead TSOT-23 packages. The LTC2067 is available in 8-lead MSOP and 10-lead DFN packages. The LTC2068 is available in 14-lead TSSOP and 16-lead 3mm  $\times$  3mm QFN packages. These devices are fully specified over the  $-40^{\circ}$ C to 85°C and  $-40^{\circ}$ C to 125°C temperature ranges.

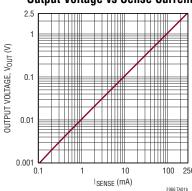
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#### TYPICAL APPLICATION

#### **Precision Micropower Low Side Current Sense**



#### **Output Voltage vs Sense Current**



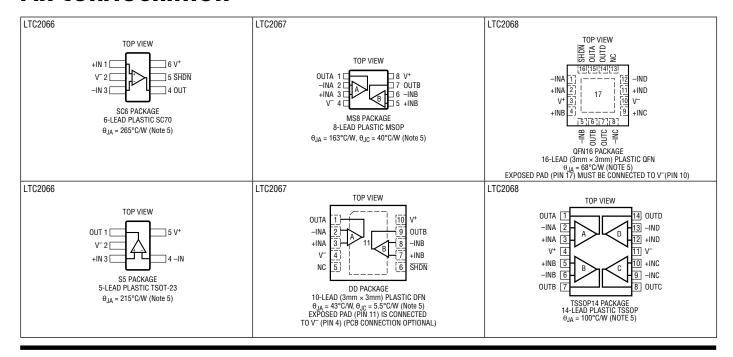
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### **ABSOLUTE MAXIMUM RATINGS** (Note 1)

#### PIN CONFIGURATION



#### ORDER INFORMATION

LEAD FREE FINISH	TAPE AND REEL	PART MARKING*	PACKAGE DESCRIPTION	TEMPERATURE RANGE
LTC2066ISC6#TRMPBF	LTC2066ISC6#TRPBF	LHDB	6-Lead Plastic SC70	-40°C to 85°C
LTC2066HSC6#TRMPBF	LTC2066HSC6#TRPBF	LHDB	6-Lead Plastic SC70	-40°C to 125°C
LTC2066IS5#TRMPBF	LTC2066IS5#TRPBF	LTHCZ	5-Lead Plastic TSOT-23	-40°C to 85°C
LTC2066HS5#TRMPBF	LTC2066HS5#TRPBF	LTHCZ	5-Lead Plastic TSOT-23	-40°C to 125°C
LTC2067IMS8#PBF	LTC2067IMS8#TRPBF	LTHDC	8-Lead Plastic MSOP	-40°C to 85°C
LTC2067HMS8#PBF	LTC2067HMS8#TRPBF	LTHDC	8-Lead Plastic MSOP	-40°C to 125°C
LTC2067IDD#PBF	LTC2067IDD#TRPBF	LHDD	10-Lead (3mm × 3mm) Plastic DFN	-40°C to 85°C
LTC2067HDD#PBF	LTC2067HDD#TRPBF	LHDD	10-Lead (3mm × 3mm) Plastic DFN	-40°C to 125°C
LTC2068IUD#PBF	LTC2068IUD#TRPBF	LHKV	16-Lead (3mm × 3mm) Plastic QFN	-40°C to 85°C
LTC2068HUD#PBF	LTC2068HUD#TRPBF	LHKV	16-Lead (3mm × 3mm) Plastic QFN	-40°C to 125°C
LTC2068IF#PBF	LTC2068IF#TRPBF	LTC2068	14-Lead TSSOP	-40°C to 85°C
LTC2068HF#PBF	LTC2068HF#TRPBF	LTC2068	14-Lead TSSOP	-40°C to 125°C

Contact the factory for parts specified with wider operating temperature ranges. \*The temperature grade is identified by a label on the shipping container. Parts ending with PBF are RoHS and WEEE compliant.

Tape and reel specifications. Some packages are available in 500 unit reels through designated sales channels with #TRMPBF suffix.

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# **ELECTRICAL CHARACTERISTICS** The $\bullet$ denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25^{\circ}C$ . Unless otherwise noted, $V_S = 1.8V$ , $V_{CM} = V_{OUT} = V_S/2$ , $V_{\overline{SHDN}} = 1.8V$ , $R_L$ to $V_S/2$ .

$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	UNITS	MAX	TYP	MIN		CONDITIONS	PARAMETER
AVOSCAT	μV μV		1		•	V <sub>S</sub> = 1.7V	Input Offset Voltage (Note 6)
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	β μV/°C	±0.03			•		Input Offset Voltage Drift (Note 6)
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	pA		±2				Input Bias Current (Note 7)
$ \begin{array}{llllllllllllllllllllllllllllllllllll$	pA		±4				Input Offset Current (Note 7)
en p-P. Input Noise Voltage         DC to 10Hz         1.9           CIN         Input Capacitance         Differential Common Mode         3.3 3.5           V <sub>CMR</sub> Input Voltage Range         Guaranteed by CMRR         • (V*) + 0.1 (V*) +	fA/√Hz		35			f ≤ 100Hz	Input Noise Current Spectral Density
CiN         Input Capacitance         Differential Common Mode Common Mode Common Mode S.3.5         3.3 3.5         3.3 3.5         3.5         VCMR         Input Voltage Range         Guaranteed by CMRR         ● (V⁻) − 0.1         (V²) + 0.         (V²) + 0.         (V⁻) − 0.1         (V²) + 0.         (V²) + 0.         (V²) + 0.         (V²) + 0.         (V²) + 0.1V to (V²) + 0	nV/√Hz		90			f ≤ 100Hz	Input Noise Voltage Spectral Density
Common Mode   3.5	μV <sub>P-P</sub>		1.9			DC to 10Hz	Input Noise Voltage
CMRR         Common Mode Rejection Ratio (Note 8)         V <sub>OM</sub> = (V^-) − 0.1V to (V^+) + 0.1V R <sub>L</sub> = 499k         103 123           PSRR         Power Supply Rejection Ratio         V <sub>S</sub> = 1.7V to 5.25V R <sub>L</sub> = 499k         108 126           A <sub>VOL</sub> Open Loop Gain         V <sub>OUT</sub> = (V^-) + 0.1V to (V^+) − 0.1V, R <sub>L</sub> = 499k         135           V <sub>OL</sub> Output Voltage Swing Low (V <sub>OUT</sub> − V^-)         R <sub>L</sub> = 499k         0.05           R <sub>L</sub> = 10k         3 10 20           V <sub>OH</sub> Output Voltage Swing High (V^+ − V <sub>OUT</sub> )         R <sub>L</sub> = 499k         0.1           R <sub>L</sub> = 10k         4.5 10 50         10.4 50           Sinking         10.4 13 50         50           SR         Slew Rate         A <sub>V</sub> = +1         17.5 60           GBW         Gain Bandwidth Product         R <sub>L</sub> = 499k         100           t <sub>ON</sub> Power-Up Time         0.4 10           f <sub>C</sub> Internal Chopping Frequency         25           V <sub>S</sub> Supply Current per Amplifier         No Load 40°C to 85°C 40°C 60 125°C         7.4 10 125.5 25           In Shutdown (SHDN = V <sup>-</sup> ) 40°C to 85°C 40°C 60 125°C         17.0 25.0 500	pF pF		3.3 3.5				Input Capacitance
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	).1 V	$(V^+) + 0.1$		(V <sup>-</sup> ) - 0.1	•	Guaranteed by CMRR	Input Voltage Range
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	dB dB		123		•	V <sub>CM</sub> = (V <sup>-</sup> ) - 0.1V to (V <sup>+</sup> ) + 0.1V R <sub>L</sub> = 499k	Common Mode Rejection Ratio (Note 8)
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	dB dB		126		•		Power Supply Rejection Ratio
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	dB		135			$V_{OUT} = (V^-) + 0.1V \text{ to } (V^+) - 0.1V, R_L = 499k$	Open Loop Gain
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	mV		0.05			R <sub>L</sub> = 499k	Output Voltage Swing Low (V <sub>OUT</sub> – V <sup>-</sup> )
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	mV mV		3		•	R <sub>L</sub> = 10k	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	mV		0.1			R <sub>L</sub> = 499k	Output Voltage Swing High (V+ – V <sub>OUT</sub> )
Sinking   10.4   13	mV mV		4.5		•	R <sub>L</sub> = 10k	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	mA mA		7.5		•	Sourcing	Output Short Circuit Current
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	mA mA		13		•	Sinking	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	V/ms		17.5			A <sub>V</sub> = +1	Slew Rate
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	kHz		100			R <sub>L</sub> = 499k	Gain Bandwidth Product
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	ms		0.4				Power-Up Time
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	kHz		25				Internal Chopping Frequency
-40°C to 85°C	V	5.25		1.7	•	Guaranteed by PSRR	Supply Voltage Range
-40°C to 85°C       ●       250         -40°C to 125°C       ●       500	μΑ μΑ μΑ	12.5	7.4		• •	-40°C to 85°C	Supply Current per Amplifier
V <sub>H</sub>   SHDN Pin Threshold, Logic High (Referred to V <sup>-</sup> )   • 1.0	nA nA	250	90		•	In Shutdown (SHDN = V <sup>-</sup> ) -40°C to 85°C	
11 / 0 0 ( /	V			1.0	•		SHDN Pin Threshold, Logic High (Referred to V <sup>-</sup> )
V <sub>L</sub> SHDN Pin Threshold, Logic Low (Referred to V <sup>−</sup> ) 0.65	V	0.65			•		, , ,
$I_{\overline{SHDN}}$ $\overline{SHDN}$ Pin Current $V_{\overline{SHDN}} = 0V$ $\bullet$ $-150$ $-20$	nA	-20		-150	•	$V_{\overline{SHDN}} = 0V$	SHDN Pin Current

## **ELECTRICAL CHARACTERISTICS** The $\bullet$ denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25^{\circ}C$ . Unless otherwise noted, $V_S = 5V$ , $V_{CM} = V_{OUT} = V_S/2$ , $V_{\overline{SHDN}} = 5V$ , $R_L$ to $V_S/2$ .

SYMBOL	PARAMETER CONDITIONS			MIN	TYP	MAX	UNITS
$V_{0S}$	Input Offset Voltage (Note 6)	V <sub>S</sub> = 5.25V			1	±5	μV
$\Delta V_{OS}/\Delta T$	Input Offset Voltage Drift (Note 6)	-40°C to 85°C				±10 ±0.02	μV μV/°C
Δν 08/Δ ι	Imput offset voltage Drift (Note 6)	-40°C to 35°C	•			±0.02 ±0.04	μV/°C
I <sub>B</sub>	Input Bias Current				±5	±35	pA
		-40°C to 85°C -40°C to 125°C	•			±50 ±150	pA
I <sub>OS</sub>	Input Offset Current	LTC2066, LTC2067			±10	±130	pA pA
105	input onset ourrent	-40°C to 85°C	•		±10	±50	pA
		–40°C to 125°C	•			±150	pA
		LTC2068 -40°C to 85°C			±10	±65 ±70	pA pA
		-40°C to 125°C	•			±170	pΑ
i <sub>n</sub>	Input Noise Current Spectral Density	f ≤ 100Hz			35		fA/√Hz
e <sub>n</sub>	Input Noise Voltage Spectral Density	f ≤ 100Hz			80		nV/√Hz
e <sub>n P-P</sub>	Input Noise Voltage	DC to 10Hz			1.7		μV <sub>P-P</sub>
C <sub>IN</sub>	Input Capacitance	Differential			3.3		pF
	Lagrat Vallaga Dagga	Common Mode		(A F-) O 4	3.5	0.45 O.4	pF V
V <sub>CMR</sub> CMRR	Input Voltage Range	Guaranteed by CMRR	•	(V <sup>-</sup> ) - 0.1	104	$(V^+) + 0.1$	
UNIKK	Common Mode Rejection Ratio	$V_{CM} = (V^{-}) - 0.1V$ to $(V^{+}) + 0.1V$ $R_{L} = 499k$	•	111 108	134		dB dB
PSRR	Power Supply Rejection Ratio	V <sub>S</sub> = 1.7V to 5.25V		108	126		dB
EMIRR	EMI Rejection Ratio	R <sub>L</sub> = 499k f = 400MHz	•	106	66		dB dB
EIVIINN	$V_{RF} = 100 \text{mV}_{PK}$	f = 900MHz			79		dВ
	$EMIRR = 20 \bullet log(V_{RF}/\Delta V_{OS})$	f = 1800MHz			90		dB
	Onen Lean Cain	f = 2400MHz		110	76		dB
A <sub>VOL</sub>	Open Loop Gain	$V_{OUT} = (V^-) + 0.1V \text{ to } (V^+) - 0.1V, R_L = 499k$	•	112 110	140		dB dB
$V_{OL}$	Output Voltage Swing Low (V <sub>OUT</sub> – V <sup>-</sup> )	R <sub>L</sub> = 499k			0.1		mV
		R <sub>L</sub> = 10k			5.5	15	mV
		-	•			20	mV
$V_{OH}$	Output Voltage Swing High (V <sup>+</sup> – V <sub>OUT</sub> )	R <sub>L</sub> = 499k			0.15		mV
		R <sub>L</sub> = 10k	•		7	15 20	mV mV
I <sub>SC</sub>	Output Short Circuit Current	Sourcing		30	51		mA
.30			•	16	•		mA
		Sinking		20	48		mA
<u> </u>	Olava Pata		•	5	47.5		mA
SR	Slew Rate	A <sub>V</sub> = +1			17.5		V/ms
GBW	Gain Bandwidth Product	R <sub>L</sub> = 499k			100		kHz
t <sub>ON</sub>	Power-Up Time				0.4		ms
f <sub>C</sub>	Internal Chopping Frequency	0 11 0000	_	ļ . <u></u>	25		kHz
Vs	Supply Voltage Range	Guaranteed by PSRR	•	1.7		5.25	V
I <sub>S</sub>	Supply Current per Amplifier	No Load -40°C to 85°C			7.5	10 12.5	μA μA
		-40°C to 125°C	•			20	μΑ

**ELECTRICAL CHARACTERISTICS** The  $\bullet$  denotes the specifications which apply over the full operating temperature range, otherwise specifications are at  $T_A = 25^{\circ}C$ . Unless otherwise noted,  $V_S = 5V$ ,  $V_{CM} = V_{OUT} = V_S/2$ ,  $V_{\overline{SHDN}} = 5V$ ,  $R_L$  to  $V_S/2$ .

SYMBOL	PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
		In Shutdown (SHDN = V <sup>-</sup> ) -40°C to 85°C	•		90	170 250	nA nA
		–40°C to 125°C	•			500	nA
$V_{H}$	SHDN Pin Threshold, Logic High (Referred to V <sup>-</sup> )		•	1.8			V
$V_L$	SHDN Pin Threshold, Logic Low (Referred to V <sup>-</sup> )		•			0.8	V
I <sub>SHDN</sub>	SHDN Pin Current	V <sub>SHDN</sub> = 0V	•	-150		-20	nA

**Note 1:** Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

**Note 2:** The inputs are protected by two series connected ESD protection diodes to each power supply. The input current should be limited to less than 10mA. The input voltage should not exceed 300mV beyond the power supply.

**Note 3:** A heat sink may be required to keep the junction temperature below the absolute maximum rating when the output is shorted indefinitely.

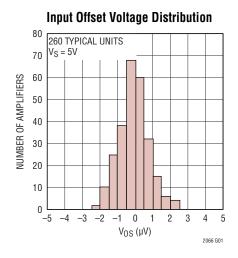
**Note 4:** The LTC2066I/LTC2067I/LTC2068I is guaranteed to meet specified performance from  $-40^{\circ}$ C to 85°C. The LTC2066H/LTC2067H/LTC2068H is guaranteed to meet specified performance from  $-40^{\circ}$ C to 125°C.

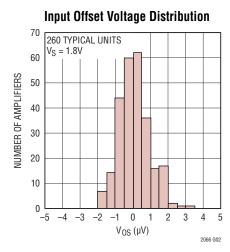
**Note 5:** Thermal resistance varies with the amount of PC board metal connected to the package. The specified values are for short traces connected to the leads.

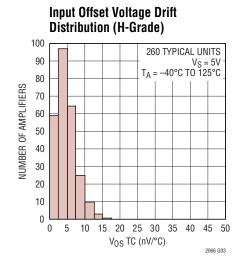
**Note 6:** These parameters are guaranteed by design. Thermocouple effects preclude measurements of these voltage levels during automated testing.  $V_{OS}$  is measured to a limit determined by test equipment capability.

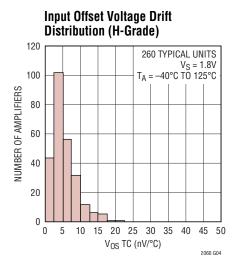
**Note 7:** Input Bias Current, Input Offset Current and Open Loop Gain are only production tested at 5V. Input Bias Current and Input Offset Current at 1.8V are expected to meet 5V specifications.

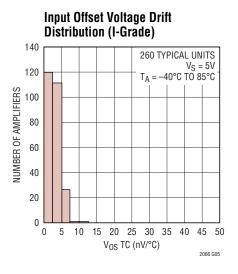
**Note 8:** Minimum specifications for these parameters are limited by noise and the capabilities of the automated test system.

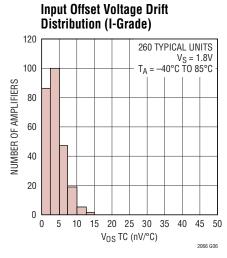


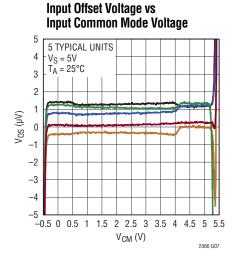


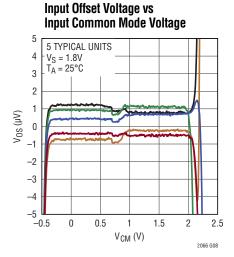


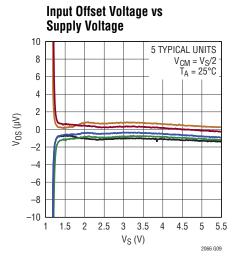




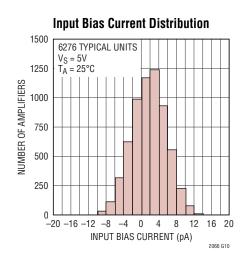


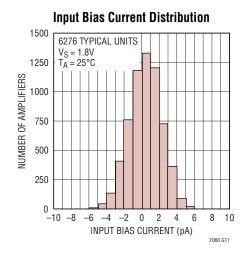


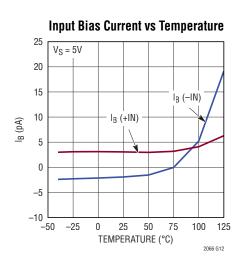


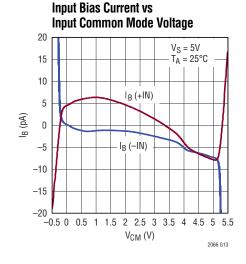


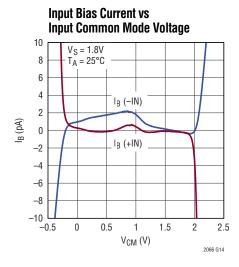
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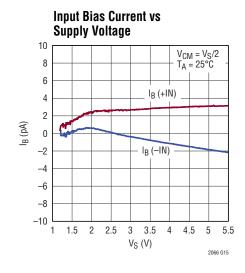




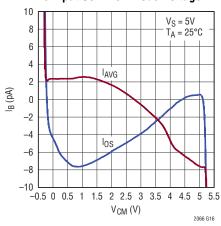




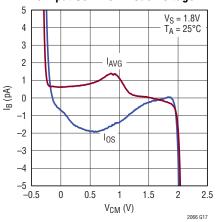




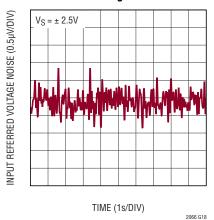
Input Offset and Average Current vs Input Common Mode Voltage



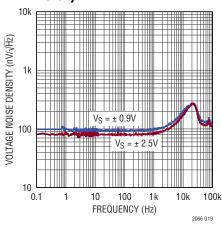
Input Offset and Average Current vs Input Common Mode Voltage



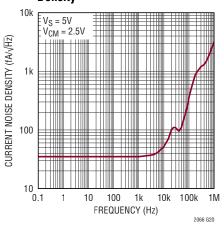
DC to 10Hz Voltage Noise



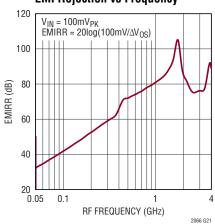
Input Referred Voltage Noise Density



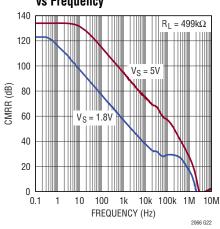
Input Referred Current Noise Density



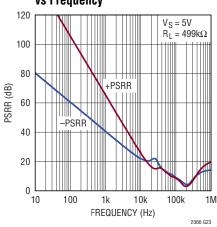
**EMI Rejection vs Frequency** 



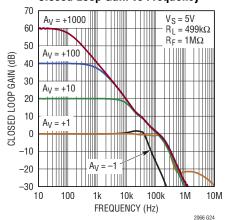
Common Mode Rejection Ratio vs Frequency



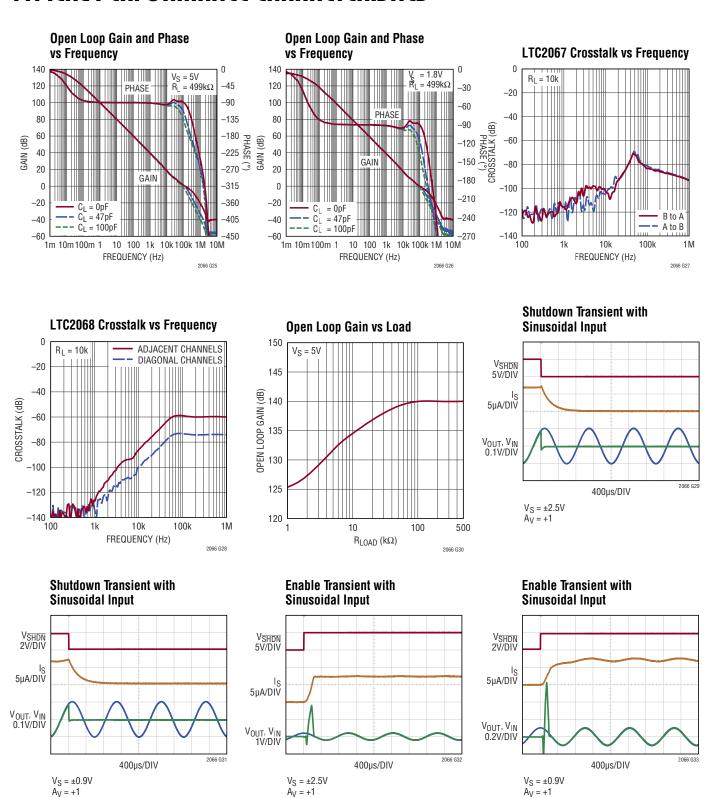
Power Supply Rejection Ratio vs Frequency



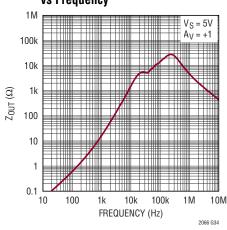
#### **Closed Loop Gain vs Frequency**



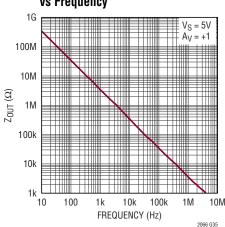
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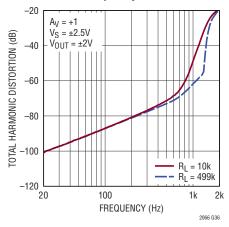
Closed Loop Output Impedance vs Frequency



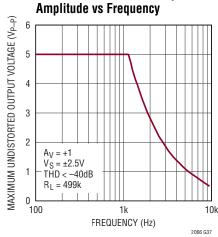
## Output Impedance in Shutdown vs Frequency



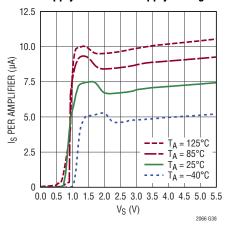
**THD vs Frequency** 



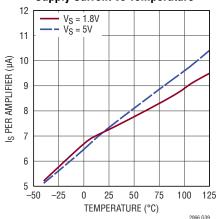
Maximum Undistorted Output



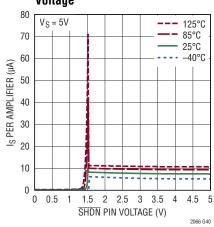
Supply Current vs Supply Voltage



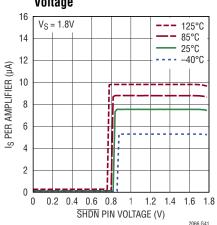
**Supply Current vs Temperature** 



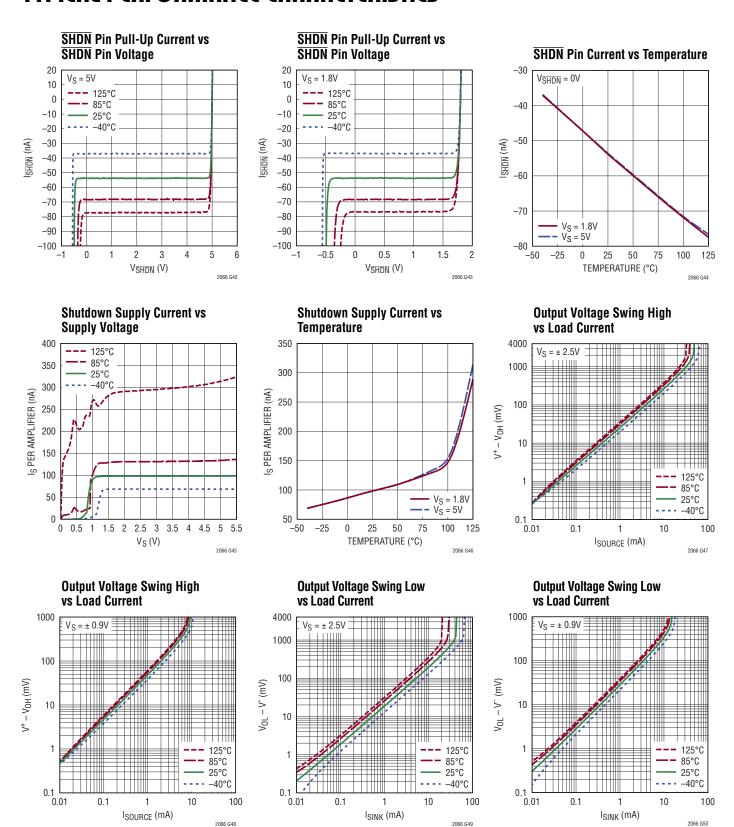
Supply Current vs SHDN Pin Voltage



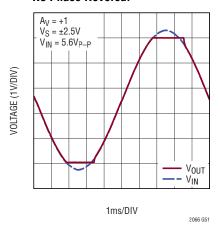
Supply Current vs SHDN Pin Voltage



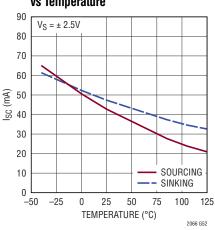
Rev. B



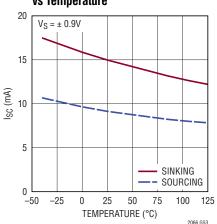
#### No Phase Reversal



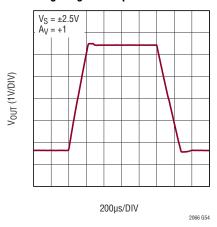
## Output Short Circuit Current vs Temperature



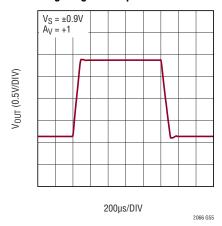
## Output Short Circuit Current vs Temperature



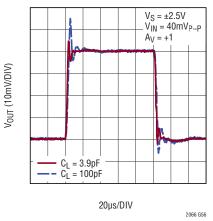
#### **Large Signal Response**



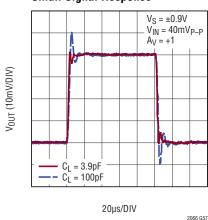
#### Large Signal Response



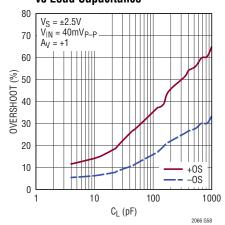
**Small Signal Response** 



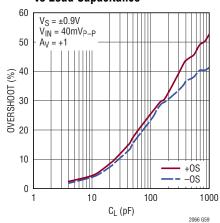
#### **Small Signal Response**



## Small Signal Overshoot vs Load Capacitance

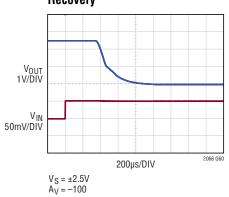


## Small Signal Overshoot vs Load Capacitance

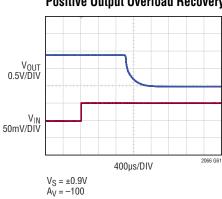


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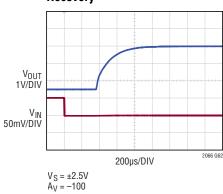




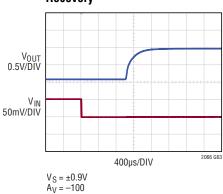
**Positive Output Overload Recovery** 



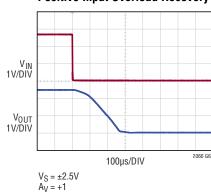
**Negative Output Overload** Recovery



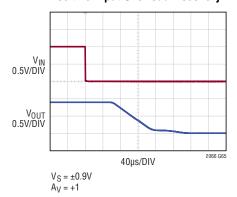
#### **Negative Output Overload** Recovery



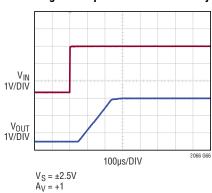
#### **Positive Input Overload Recovery**



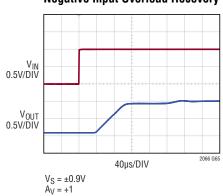
#### **Positive Input Overload Recovery**



#### **Negative Input Overload Recovery**



#### **Negative Input Overload Recovery**



#### PIN FUNCTIONS

**OUT:** Amplifier Output

-IN: Inverting Amplifier Input

+IN: Noninverting Amplifier Input

 ${f V}^+$ : Positive Power Supply. A bypass capacitor should be

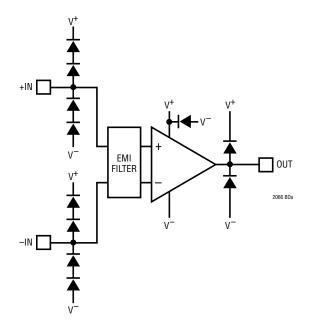
used between supply pins and ground.

**V**<sup>-</sup>: Negative Power Supply. A bypass capacitor should be used between supply pins and ground.

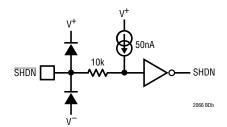
**SHDN:** Shutdown Control Pin. The  $\overline{SHDN}$  pin threshold is referenced to V<sup>-</sup>. If tied to V<sup>+</sup>, the part is enabled. If tied to V<sup>-</sup>, the part is disabled and draws less than 170nA of supply current per amplifier. It is recommended not to float this pin.

### **BLOCK DIAGRAM**

#### **Amplifier**



#### **Shutdown Circuit**



#### Using the LTC2066/LTC2067/LTC2068

The LTC2066/LTC2067/LTC2068 are single, dual, and quad zero-drift operational amplifiers with the open-loop voltage gain and bandwidth characteristics of a conventional operational amplifier. Advanced circuit techniques allow the LTC2066/LTC2067/LTC2068 to operate continuously through its entire bandwidth while self-calibrating unwanted errors.

#### **Input Voltage Noise**

Zero-drift amplifiers like the LTC2066/LTC2067/LTC2068 achieve low input offset voltage and 1/f noise by heterodyning DC and flicker noise to higher frequencies. In early zero-drift amplifiers, this process resulted in idle tones at the self-calibration frequency, often referred to as the chopping frequency. These artifacts made early zero-drift amplifiers difficult to use. The advanced circuit techniques used by the LTC2066/LTC2067/LTC2068 suppress these spurious artifacts, allowing for trouble-free use.

#### **Input Current Noise**

For applications with high source and feedback impedances, input current noise can be a significant contributor to total output noise. For this reason, it is important to consider noise current interaction with circuit elements placed at the amplifier's inputs.

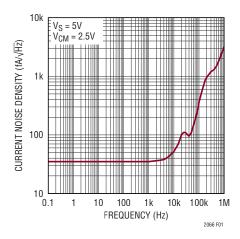


Figure 1. Input Current Noise Spectrum

The current noise spectrum of the LTC2066/LTC2067/LTC2068 is shown in Figure 1. Low input current noise is achieved through the use of MOSFET input devices and self-calibration techniques to eliminate 1/f current noise. As with all zero-drift amplifiers, there is an increase in current noise at the offset-nulling frequency. This phenomenon is discussed in the Input Bias Current and Clock Feedthrough section.

Input current noise also rises with frequency due to capacitive coupling of MOSFET channel thermal noise.

#### Input Bias Current and Clock Feedthrough

The input bias current of zero-drift amplifiers has different characteristics than that of a traditional operational amplifier. The specified input bias current is the DC average of transient currents which conduct due to the input stage's switching circuitry. In addition to this, junction leakages can contribute additional input bias current at elevated temperatures. Through careful design and the use of an innovative boot-strap circuit, the input bias current of the LTC2066/LTC2067/LTC2068 does not exceed 35pA at room and 150pA over the full temperature range. This minimizes bias current induced errors even in high impedance circuits.

Transient switching currents at the input interact with source and feedback impedances, producing error voltages which are indistinguishable from a valid input signal. The resulting error voltages are amplified by the amplifier's closed-loop gain, which acts as a filter, attenuating frequency components above the circuit bandwidth. This phenomenon is known as clock feedthrough and is present in all zero-drift amplifiers. Understanding the cause and effect of clock feedthrough is important when using zero-drift amplifiers.

For zero-drift amplifiers, clock feedthrough is proportional to source and feedback impedances, as well as the magnitude of the transient currents. These transient currents have been minimized in the LTC2066/LTC2067/LTC2068 to allow use with high source and feedback impedances. Many circuit designs require high feedback impedances

to minimize power consumption and/or require a sensor which is intrinsically high impedance. In these cases, a capacitor can be used, either at the input or across the feedback resistor, to limit the bandwidth of the closed-loop system. Doing so will effectively filter out the clock feedthrough signal.

#### Thermocouple Effects

In order to achieve accuracy on the microvolt level, thermocouple effects must be considered. Any connection of dissimilar metals forms a thermoelectric junction and generates a small temperature-dependent voltage. Also known as the Seebeck Effect, these thermal EMFs can be the dominant error source in low-drift circuits.

Connectors, switches, relay contacts, sockets, resistors, and solder are all candidates for significant thermal EMF generation. Even junctions of copper wire from different manufacturers can generate thermal EMFs of 200nV/°C, which significantly exceeds the maximum drift specification of the LTC2066/LTC2067/LTC2068. Figures 2 and 3 illustrate the potential magnitude of these voltages and their sensitivity to temperature.

In order to minimize thermocouple-induced errors, attention must be given to circuit board layout and component selection. It is good practice to minimize the number of junctions in the amplifier's input signal path and avoid connectors, sockets, switches, and relays whenever possible. If such components are required, they should be selected for low thermal EMF characteristics. Furthermore, the number, type, and layout of junctions should be matched for both inputs with respect to thermal gradients on the circuit board. Doing so may involve deliberately introducing dummy junctions to offset unavoidable junctions.

Air currents can also lead to thermal gradients and cause significant noise in measurement systems. It is important to prevent airflow across sensitive circuits. Doing so will often reduce thermocouple noise substantially. A summary of techniques can be found in Figure 4.

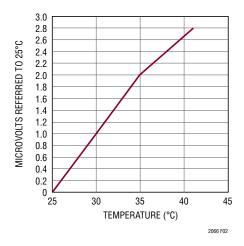


Figure 2. Thermal EMF Generated by Two Copper Wires from Different Manufacturers

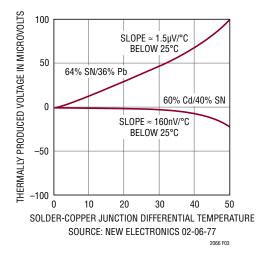
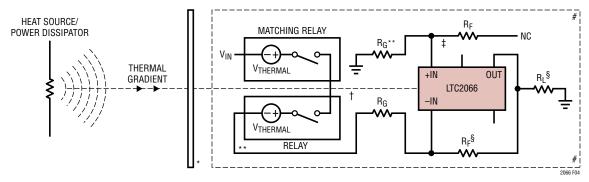


Figure 3. Solder-Copper Thermal EMFs

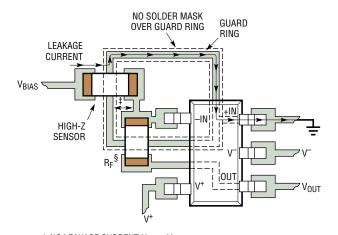
#### **Leakage Effects**

Leakage currents into high impedance signal nodes can easily degrade measurement accuracy of sub-nanoamp signals. High voltage and high temperature applications are especially susceptible to these issues. Quality insulation materials should be used, and insulating surfaces should be cleaned to remove fluxes and other residues. For humid environments, surface coating may be necessary to provide a moisture barrier.



- \* CUT SLOTS IN PCB FOR THERMAL ISOLATION.
- \*\* INTRODUCE DUMMY JUNCTIONS AND COMPONENTS TO OFFSET UNAVOIDABLE JUNCTIONS OR CANCEL THERMAL EMFS.
- ALIGN INPUTS SYMMETRICALLY WITH RESPECT TO THERMAL GRADIENTS.
- INTRODUCE DUMMY TRACES AND COMPONENTS FOR SYMMETRICAL THERMAL HEAT SINKING.
- LOADS AND FEEDBACK CAN DISSIPATE POWER AND GENERATE THERMAL GRADIENTS. BE AWARE OF THEIR THERMAL EFFECTS.
- COVER CIRCUIT TO PREVENT AIR CURRENTS FROM CREATING THERMAL GRADIENTS.

Figure 4. Techniques for Minimizing Thermocouple-Induced Errors



- ‡ NO LEAKAGE CURRENT, V<sub>-IN</sub> = V<sub>+IN</sub> § AVOID DISSIPATING SIGNIFICANT AMOUNTS OF POWER IN THIS RESISTOR. IT WILL GENERATE THERMAL GRADIENTS WITH RESPECT TO THE INPUT PINS AND LEAD TO THERMOCOUPLE-INDUCED ERROR. THERMALLY ISOLATE OR ALIGN WITH INPUTS IF RESISTOR WILL CAUSE HEATING.
- V<sub>BIAS</sub> HIGH-Z SENSOR

  V<sub>IN</sub> R<sub>IN</sub>

  LEAKAGE CURRENT IS ABSORBED BY GROUND INSTEAD OF CAUSING A MEASUREMENT ERROR.

  Z086 H

  COURTENT

  VOUT

  LEAKAGE CURRENT IS ABSORBED BY GROUND INSTEAD OF CAUSING A MEASUREMENT ERROR.

Figure 5. Example Layout of Inverting Amplifier with Leakage Guard Ring

Board leakage can be minimized by encircling the input connections with a guard ring operated at a potential very close to that of the inputs. The ring must be tied to a low impedance node. For inverting configurations, the guard ring should be tied to the potential of the positive input (+IN). For noninverting configurations, the guard ring should be tied to the potential of the negative input (-IN). In order for this technique to be effective, the guard ring must not be covered by solder mask. Ringing both sides of the printed circuit board may be required. See Figure 5 for an example of proper layout.

#### Shutdown Mode

The LTC2066 in the SC70 package, the LTC2067 in the DFN package, and the LTC2068 in the QFN package feature a shutdown mode for low-power applications. In the OFF state, each amplifier draws less than 170nA of supply current and the outputs present a high impedance to external circuitry.

Shutdown operation is accomplished by tying  $\overline{SHDN}$  below  $V_L$ . If the shutdown feature is not required, it is recommended that  $\overline{SHDN}$  be tied to  $V^+$ . A current source pulls the  $\overline{SHDN}$  pin high to keep the amplifier in the ON state when the pin is floated, however this may not be reliable at elevated temperatures due to board leakage (see  $\overline{SHDN}$  Circuit Block Diagram, page 14). For operation in noisy environments, a capacitor between  $\overline{SHDN}$  and  $V^+$  is recommended to prevent noise from changing the shutdown state. When there is a danger of  $\overline{SHDN}$  being pulled beyond the supply rails, resistance in series with the  $\overline{SHDN}$  pin is recommended to limit the resulting current.

#### **Start-Up Characteristics**

Micropower op amps are often not micropower during start-up, which can cause problems when used on low current supplies. Large transient currents can conduct during power-up until the internal bias nodes settle to their final values. A large amount of current can be drawn from the supplies during this transient, which can sustain for several milliseconds in the case of a micropower part.

In the worst case, there may not be enough supply current available to take the system up to nominal voltages. In other cases, this transient power-up current will lead to added power loss in duty-cycled applications.

A way to quantify the transient current loss is to integrate the supply current during power-up to examine the total charge loss. If there were no additional transient current, the integrated supply current would appear as a smooth, straight line with a slope equal to the DC supply current of the part. Any deviation from a straight line indicates additional transient current that is drawn from the supply. The LTC2066/LTC2067/LTC2068 have been designed to minimize this charge loss during power-up so that power can be conserved in duty-cycled applications. Figure 6 shows the integrated supply current (i.e. charge) of the LTC2066 during power-up. Likewise, Figure 7 shows the charge loss due to enabling and disabling the part via the SHDN pin.

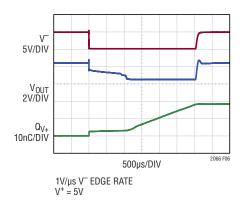


Figure 6. LTC2066 Charge Loss During Power-Up

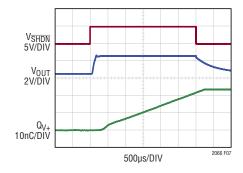


Figure 7. LTC2066 Charge Loss Due to Enabling and Disabling via SHDN Pin

There are benefits when the SHDN pin is used to disable and enable the part in duty-cycled applications, rather than powering down the external supply voltage (V<sup>+</sup>). Powering up and powering down the external supply will tend to waste charge due to charging and discharging the external decoupling capacitors. For these power-cycled applications, a relay or MOS device can be located after the decoupling capacitors to alleviate this; however there are drawbacks to this approach. The LTC2066 draws an initial charge of approximately 3nC when powered up. This recurring charge loss is unavoidable in power-cycled applications. Additionally, if the supply ramp rate exceeds 0.4V/us, an internal transient ESD clamp will trigger, conducting additional current from V<sup>+</sup> to V<sup>-</sup>. This will waste charge and can make insignificant any savings that may have been expected by power-cycling the supply. Figure 8 shows the charge loss at power-up.

The shutdown pin can be used to overcome these limitations in duty-cycled applications. The typical charge loss transitioning into and out of shutdown is only 2.3nC. Since the supply is not transitioned, the external decoupling capacitors do not draw charge from the supply.

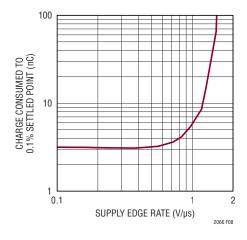


Figure 8. LTC2066 Power-Up Charge vs Supply Edge Rate

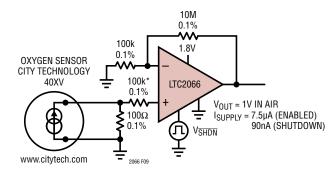
#### **Gas Sensor**

This low power precision gas sensor circuit operates in an oxygen level range of 0% to 30%, with a nominal output of 1V in normal atmospheric oxygen concentrations (20.9%) when the gas sensor has been fully initialized. Total active power consumption is less than  $10.1\mu A$  on a single rail supply.

Since this gas sensor produces  $100\mu A$  in a normal oxygen environment and requires a  $100\Omega$  load resistor, the resulting input signal is typically around 10mV. The LTC2066's rail-to-rail input means no additional DC level shifting is necessary, all the way down to very low oxygen concentrations.

Due to the extremely low input offset voltage of the LTC2066, which is  $1\mu V$  typically and  $5\mu V$  maximum, it is possible to gain up the mV-scale input signal substantially without introducing significant error. In the configuration shown in Figure 9, with a noninverting gain of 101V/V, the worst-case input offset results in a maximum of 0.5mV offset on the 1V output, or 0.05% error.

Although the  $100k\Omega$  resistor in series with the gas sensor does not strictly have the same precision requirement as the  $10M\Omega$  and  $100k\Omega$  resistors that set the gain, it is important to use a similar resistor at both input terminals. This helps to minimize additional offset voltage at the inputs due to thermocouple effects and bias current, hence the similar 0.1% precision requirement.



\*RESISTOR CANCELS OUT PARASITIC SEEBECK EFFECT VOLTAGE

Figure 9. Micropower Precision Oxygen Sensor

#### **RTD Sensor**

This low power platinum resistance temperature detector (RTD) sensor circuit draws only  $43\mu A$  total supply current on a minimum 2.6V rail, and is accurate to within  $\pm 1^{\circ}C$  at room temperature, including all error intrinsic to the Vishay PTS Class F0.3 Variant RTD. It covers the temperature range from  $-40^{\circ}C$  to  $85^{\circ}C$  in  $10\text{mV/}^{\circ}C$  increments and produces an output of 1V at nominal room temperature of  $25^{\circ}C$ .

The LTC2066's extremely low typical offset of  $1\mu V$  and typical input bias current of 5pA allows for the use of a very low excitation current in the RTD. Thus, self-heating is negligible, improving accuracy.

The LT5400-3, B-grade, is used to provide a  $\pm 0.025\%$  matched resistor network that is effectively a precision 131:1 voltage divider. This precision divider forms one half of a bridge circuit, with the 0.1%  $110k\Omega$  and RTD in the other branch. Note that the  $110k\Omega$ 's precision requirement is to ensure matching with the RTD. The  $11k\Omega$  R2 serves to provide a DC offset for the entire bridge so

that the output is 1V at room temperature. Since bridge imbalances can lead to error, it is recommended to minimize the length of the leads connecting the RTD to reduce additional lead resistance.

The LT6656-2.048 reference helps create a known excitation current in the RTD at each temperature of operation, and also acts as a supply for the LTC2066, all while using less than 1 $\mu$ A itself. The LT6656 can accept input voltages anywhere between 2.6V and 18V, allowing for flexibility in selection of supply voltage while maintaining a fixed output range. The LT6656 reference can easily source the 43 $\mu$ A required to run the entire circuit, thanks to the LTC2066's 10 $\mu$ A maximum supply current and ability to handle microvolt signals produced by the RTD under low excitation current.

Care should be taken to minimize thermocouple effects by preventing significant thermal gradients between the two op amp inputs. It is also important to choose feedback and series resistors that are low-tempco to minimize error due to drift over the entire temperature range.

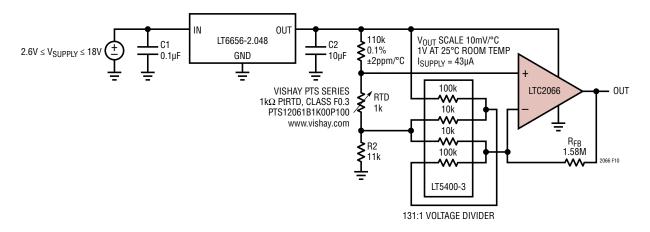


Figure 10. RTD Sensor

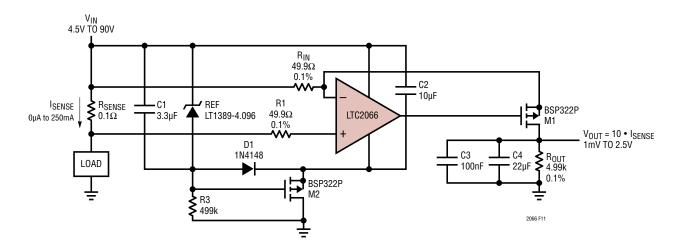


Figure 11. High Side Current Sense

#### 90V High Side Current Sense

This micropower precision LTC2066 high side current sense circuit measures currents from  $100\mu A$  to 250mA over a 4.5V to 90V input voltage range.

The output of this circuit is:

$$V_{OUT} = \frac{R_{OUT} \cdot R_{SENSE}}{R_{IN}} I_{SENSE} = 10 \cdot I_{SENSE}$$

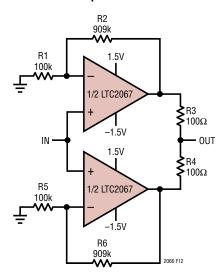
The LTC2066's low typical input offset voltage of  $1\mu V$  and low input bias current of 5pA contribute output errors that are much smaller than the error due to precision limitations of the resistors used. Thus, output accuracy is mainly set by the accuracy of the resistors  $R_{SENSE}$ ,  $R_{IN}$ ,

and  $R_{OUT}$ . R1 helps cancel out parasitic Seebeck effect voltages at -IN by balancing with an identical voltage at +IN.

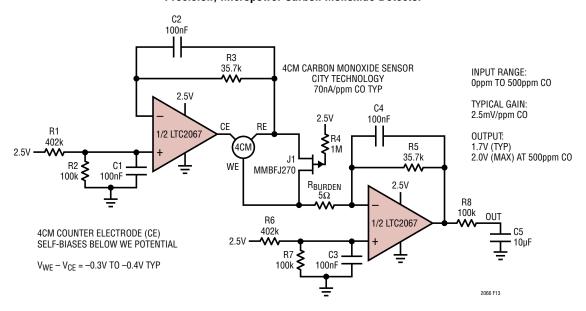
The LT1389-4.096 reference, along with the bootstrap circuit composed of M2, R3, and D1, establishes a very low power isolated 3V rail that protects the LTC2066 from reaching its absolute maximum voltage of 5.5V while allowing for much higher input voltages.

Since the LTC2066's gain-bandwidth product is 100kHz, it is recommended to use this circuit to measure currents that do not change faster than 10kHz. Note that the output filter as drawn will limit the frequency to 1.5Hz, which optimizes for lowest noise. If this output filter bandwidth is too narrow, removing C4 leads to an output filter with 318Hz bandwidth, created by C3 and  $R_{OUT}$ 

#### Parallel LTC2067 Amplifiers to Reduce Noise by $\sqrt{2}$

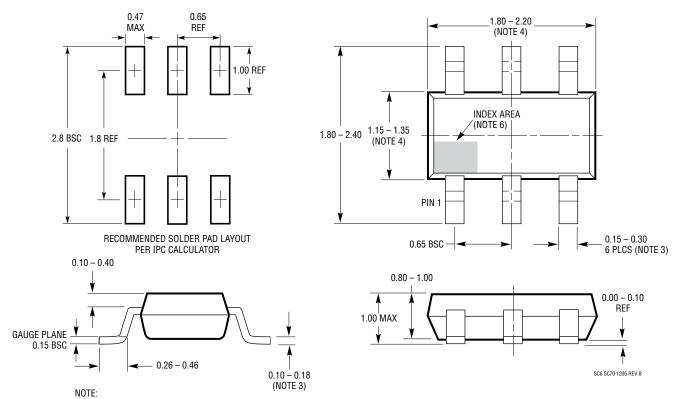


#### Precision, Micropower Carbon Monoxide Detector



#### SC6 Package 6-Lead Plastic SC70

(Reference LTC DWG # 05-08-1638 Rev B)



- 1. DIMENSIONS ARE IN MILLIMETERS
- 2. DRAWING NOT TO SCALE
- 3. DIMENSIONS ARE INCLUSIVE OF PLATING
- 4. DIMENSIONS ARE EXCLUSIVE OF MOLD FLASH AND METAL BURR
- 5. MOLD FLASH SHALL NOT EXCEED  $0.254 \mathrm{mm}$
- 6. DETAILS OF THE PIN 1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE INDEX AREA
- 7. EIAJ PACKAGE REFERENCE IS EIAJ SC-70
- 8. JEDEC PACKAGE REFERENCE IS MO-203 VARIATION AB

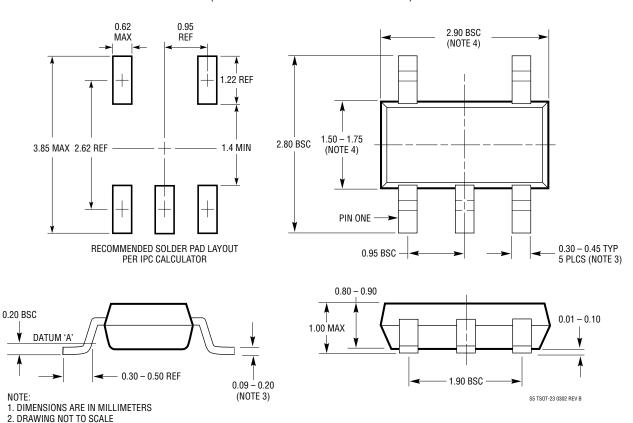
3. DIMENSIONS ARE INCLUSIVE OF PLATING

5. MOLD FLASH SHALL NOT EXCEED 0.254mm 6. JEDEC PACKAGE REFERENCE IS MO-193

4. DIMENSIONS ARE EXCLUSIVE OF MOLD FLASH AND METAL BURR

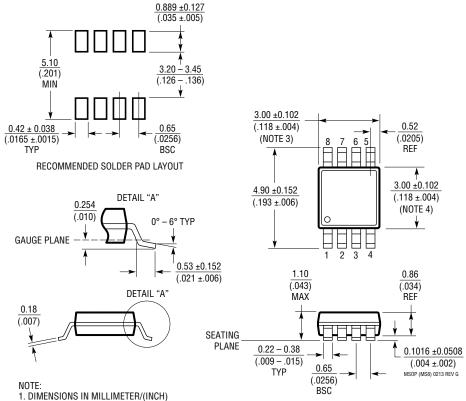
#### S5 Package 5-Lead Plastic TSOT-23

(Reference LTC DWG # 05-08-1635 Rev B)



#### **MS8 Package** 8-Lead Plastic MSOP

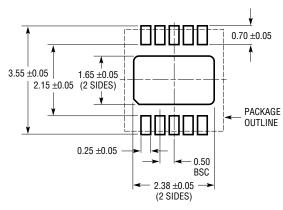
(Reference LTC DWG # 05-08-1660 Rev G)



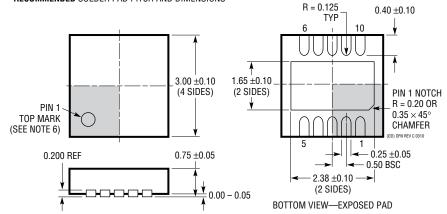
- 2. DRAWING NOT TO SCALE
- 3. DIMENSION DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.152mm (.006") PER SIDE 4. DIMENSION DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSIONS.
- INTERLEAD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.152mm (.006") PER SIDE
- 5. LEAD COPLANARITY (BOTTOM OF LEADS AFTER FORMING) SHALL BE 0.102mm (.004") MAX

#### **DD Package** 10-Lead Plastic DFN (3mm × 3mm)

(Reference LTC DWG # 05-08-1699 Rev C)







#### NOTE:

- DRAWING TO BE MADE A JEDEC PACKAGE OUTLINE M0-229 VARIATION OF (WEED-2).
   CHECK THE LTC WEBSITE DATA SHEET FOR CURRENT STATUS OF VARIATION ASSIGNMENT
- 2. DRAWING NOT TO SCALE
- 2. DRAWING NOT TO SCALE
  3. ALL DIMENSIONS ARE IN MILLIMETERS
  4. DIMENSIONS OF EXPOSED PAD ON BOTTOM OF PACKAGE DO NOT INCLUDE
  MOLD FLASH. MOLD FLASH, IF PRESENT, SHALL NOT EXCEED 0.15mm ON ANY SIDE

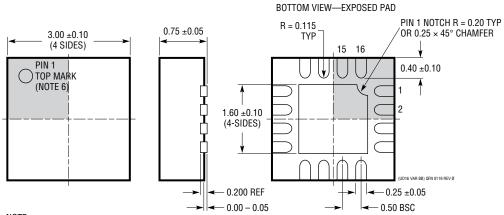
  TO SECOND AND STANDARD BY ATTER

  TO SECOND AND STANDARD BY ATTER
- 5. EXPOSED PAD SHALL BE SOLDER PLATED
- 6. SHADED AREA IS ONLY A REFERENCE FOR PIN 1 LOCATION ON THE TOP AND BOTTOM OF PACKAGE

#### **UD Package** 16-Lead Plastic QFN (3mm × 3mm)

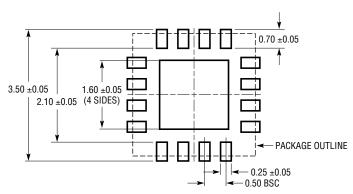
(Reference LTC DWG # 05-08-1782 Rev Ø)

#### **Exposed Pad Variation BB**



- 1. DRAWING CONFORMS TO JEDEC PACKAGE OUTLINE MO-220 VARIATION (WEED-4)
  2. DRAWING NOT TO SCALE

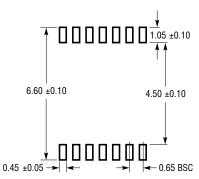
- 2. DRAWING NOT TO SCALE
  3. ALL DIMENSIONS ARE IN MILLIMETERS
  4. DIMENSIONS OF EXPOSED PAD ON BOTTOM OF PACKAGE DO NOT INCLUDE
  MOLD FLASH, MOLD FLASH, IF PRESENT, SHALL NOT EXCEED 0.15mm ON ANY SIDE
- NiPadu PPF TERMINAL FINISH
   SHADED AREA IS ONLY A REFERENCE FOR PIN 1 LOCATION ON THE TOP AND BOTTOM OF PACKAGE



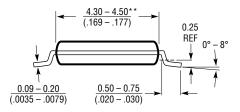
RECOMMENDED SOLDER PAD PITCH AND DIMENSIONS

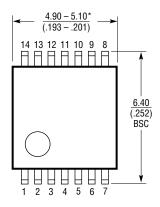
#### F Package 14-Lead Plastic TSSOP (4.4mm)

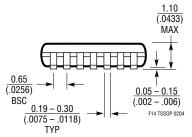
(Reference LTC DWG # 05-08-1650)



RECOMMENDED SOLDER PAD LAYOUT







#### NOTE:

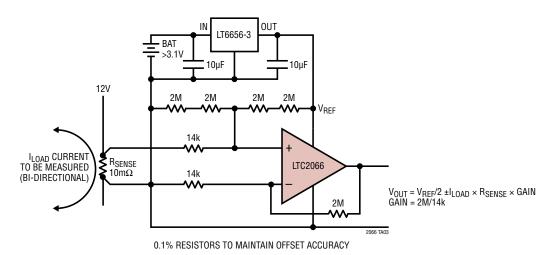
- 1. CONTROLLING DIMENSION: MILLIMETERS
- 2. DIMENSIONS ARE IN  $\frac{\text{MILLIMETERS}}{\text{(INCHES)}}$
- 3. DRAWING NOT TO SCALE
- \*DIMENSIONS DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .152mm (.006") PER SIDE
- \*\*DIMENSIONS DO NOT INCLUDE INTERLEAD FLASH. INTERLEAD FLASH SHALL NOT EXCEED .254mm (.010") PER SIDE

### **REVISION HISTORY**

REV	DATE	DESCRIPTION	PAGE NUMBER
Α	07/18	Adding LTC2067 to data sheet	All Pages
В	06/20	Added LTC2068 to data sheet	All Pages

#### TYPICAL APPLICATION

#### Battery Powered Current Sense Amplifier Floats with Sense Resistor Voltage



## **RELATED PARTS**

PART NUMBER	DESCRIPTION	COMMENTS
ADA4051-1/ADA4051-2	Micropower, Single/Dual, Zero-Drift Operational Amplifiers	7µА I <sub>S</sub> , 15µV V <sub>OS</sub> , 11.8V to 5.5V V <sub>S</sub> , 115kHz, RRIO
LTC2063/LTC2064/ LTC2065	Micropower, Low IB Single/Dual/Quad, Zero-Drift Op Amps	2μΑ I <sub>S</sub> , 5μV V <sub>OS</sub> , 1.7V to 5.25V V <sub>S</sub> , 20kHz, RRIO
LTC2054/LTC2055	Micropower, Single/Dual, Zero-Drift Operational Amplifier	130µA I <sub>S</sub> , 5µV V <sub>OS</sub> , 2.7V to 11 V V <sub>S</sub> , 500kHz, RR Output
ADA4522-1/ADA4522-2/ ADA4522-4	55V, Low Noise Zero-Drift Operational Amplifier	$900\mu A$ I <sub>S</sub> , $5.8$ nV/ $\sqrt{Hz}$ , $5\mu V$ V <sub>OS</sub> , $4.5$ V to $55$ V V <sub>S</sub> , $3$ MHz, RR Output
LTC2057/LTC2057HV	High Voltage-Low Noise Zero-Drift Operational Amplifier	4μV V <sub>OS</sub> , 1.2mA I <sub>S</sub> , 4.75V to 60V V <sub>S</sub> , 1.5MHz, RR Output
LTC2058	36V, Low Noise Zero-Drift Operational Amplifier	5μV V <sub>OS</sub> , 1.2mA I <sub>S</sub> , 4.75V to 36V V <sub>S</sub> , 2.5MHz, RR Output
LTC2050/LTC2050HV	Zero-Drift Operational Amplifier	$3\mu V V_{0S}$ , 1.5mA $I_S$ , 2.7V to 12V $V_S$ , 3MHz, RR Output
LTC2051/LTC2052	Dual/Quad Zero-Drift Operational Amplifier	3μV V <sub>OS</sub> , 1.5mA I <sub>S</sub> , 2.7V to 12V V <sub>S</sub> , 3MHz, RR Output
ADA4528-1/ADA4528-2	5V Ultra Low Noise Zero-Drift Op Amps	$5\mu$ V V <sub>OS</sub> , 5.6nV/ $\sqrt{\text{Hz}}$ , 1.7mA I <sub>S</sub> , 2.2V to 5.5V V <sub>S</sub> , 4MHz, RRIO
LT®1494/LT1495/ LT1496	1.5μA Max, Over-The-Top Precision Operational Amplifier	1.5µA I <sub>S</sub> , 375µV V <sub>OS</sub> , 2.2V to 36V V <sub>S</sub> , 2.7kHz, RRIO
LT6003/LT6004/LT6005	1.6V, 1µA Precision Rail-to-Rail Input and Output Op Amps	1μΑ I <sub>S</sub> , 500μV V <sub>OS</sub> , 1.6V to 16V V <sub>S</sub> , 2kHz, RRIO
LT6023	Micropower, Enhanced Slew Op Amp	20μA I <sub>S</sub> , 20μV V <sub>OS</sub> , 3V to 30V V <sub>S</sub> , 40kHz
LTC2053	Precision, Rail-to-Rail, Zero-Drift, PGIA	1.3mA I <sub>S</sub> , 10μV V <sub>OS</sub> , 2.7V to 12V V <sub>S</sub> , 200kHz, RRIO
LT5400	Quad Matched Resistor Network	0.01% Matching, 8ppm/°C Temp Drift , 0.2ppm/°C Temp Matching